IN THE CLAIMS:

Please amend claims 12 and 14-17, cancel claim 11 and add claim 21 as follows:

CLAIMS

- 1. (Currently Amended) A sensor, comprising:
 - a silicon substrate having a source region, a drain region and a capacitive well;
- a floating gate disposed on the silicon substrate to form a field effect transistor with the source region and drain region;

an insulating layer that separates the floating gate and a hybrid mounted top electrode having a sensitive layer formed on an underside thereof, where the sensitive layer and the insulating layer form an air gap; and

a layer of hydrophobic material on a surface of the insulating layer within the air gap.

- 2. (Previously Presented) The sensor of claim 1, where the hydrophobic layer comprises molecular chains that form a stable bond to silicon.
- (Previously Presented) The sensor of claim 2, where the molecular chains form a monolayer.
- 4. (Cancelled)
- 5. (Previously Presented) The sensor of claim 1, where the silicon semiconductor system comprises a field effect transistor.
- 6. (Previously Presented) The sensor of claim 1, where the sensor comprises a sensor from the group including a gas sensor, a pressure sensor, and an acceleration sensor.

7. (Withdrawn) A method for producing a gas sensor with a gas-sensitive layer integrated in a field effect transistor (FET) with components containing silicon, on which layer electrical signals corresponding to a target gas that is present are read by the FET, the method comprising the steps of:

coating a plurality of components containing silicon with a hydrophobic layer by silanization; and

mounting additional components belonging to the FET.

- (Withdrawn) The method of claim 6, where a silane is used for the silanization.
- 9. (Withdrawn) The method of claim 7, where a trichlorosilane is used for the silanization.
- (Withdrawn) The method of claim 8, where an n-octadecyltrichlorosilane (C₁₈H₃₇Cl₃Si) is used for the silanization.
- 11. (Cancelled)
- 12. (Currently Amended) The sensor of claim 121, where the hydrophobic coating layer comprises molecular chains that form a stable bond to silicon.
- 13. (Previously Presented) The sensor of claim 12, where the molecular chains form a monolayer.

- 14. (Currently Amended) The sensor of claim 11, where the sensor comprises a gas sensor.
- 15. (Currently Amended) The sensor of claim 11, where the sensor comprises a pressure sensor.
- 16. (Currently Amended) The sensor of claim 41, where the sensor comprises an acceleration sensor.
- 17. (Currently Amended) The sensor of claim 41, where the hydrophobic coating layer is applied by silanization.
- 18. (Previously Presented) The sensor of claim 17, where a silane is used for the silanization.
- 19. (Previously Presented) The sensor of claim 17, where a trichlorosilane is used for the silanization.
- 20. (Previously Presented) The sensor of claim 17, where an n-octadecyltrichlorosilane $(C_{18}H_{37}Cl_3Si)$ is used for the silanization.

21.(New) A gas sensor, comprising:

a silicon substrate having a source region, a drain region and a capacitive well;

a floating gate disposed on the silicon substrate to form a field effect transistor with the source region and drain region;

an insulating layer that separates the floating gate and a hybrid mounted top electrode having a gas sensitive layer formed on an underside thereof, where the gas sensitive layer and the insulating layer form an air gap; and

a layer of hydrophobic material between the insulating layer and the air gap.